

Features

- Super Low Gate Charge
- Proprietary New Trench Technolog
- Fast Recovery Body Diode

BVDSS		200	V
ID@VGS = 10V , TC = 25 °C		30	A
RDSON(MAX)	VGS = 10 V , ID = 20 A	50	mΩ

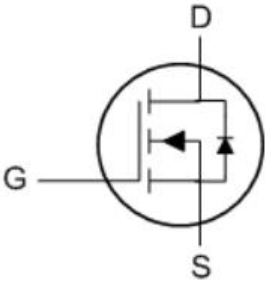

Application

- Synchronous Rectification in SMPS
- Motor Control
- Hard Switching and High Speed Circuit

Description

The JSD45N20A is the high cell density trenched N-Ch MOSFETs, which provide excellent RDSON and gate charge for applications.

The EHD45N20A meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Equivalent Circuit	Outline
	<p>TO-252</p> 

Package Marking and Ordering Information

Device Marking	Date Code	Device Package	Quantity
D45N20A	YWWXXX	TO-252	2500 pcs

Thermal Characteristic

Symbol	Parameter	Value	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹	75	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	1.1	°C/W

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
V_{DS}	Drain-Source Voltage	200	V
V_{GS}	Gate-Source Voltage	±20	V
I_D	Continuous Drain Current, V_{GS} @ 10V ¹ ($T_C=25^\circ\text{C}$)	30	A
	Continuous Drain Current, V_{GS} @ 10V ¹ ($T_C=100^\circ\text{C}$)	19	
	Continuous Drain Current, V_{GS} @ 10V ¹ ($T_A=25^\circ\text{C}$)	3.7	
	Continuous Drain Current, V_{GS} @ 10V ¹ ($T_A=70^\circ\text{C}$)	2.9	
I_{DM}	Pulsed Drain Current ²	120	A
P_D	Total Power Dissipation ⁴ ($T_C=25^\circ\text{C}$)	133	W
	Total Power Dissipation ⁴ ($T_C=100^\circ\text{C}$)	45	
	Total Power Dissipation ⁴ ($T_A=25^\circ\text{C}$)	1.7	
	Total Power Dissipation ⁴ ($T_A=70^\circ\text{C}$)	1.1	
E_{AS}	Single Pulse Avalanche Energy ³	200	mJ
I_{AS}	Avalanche Current	20	A
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 To 150	°C

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Static Characteristics						
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	200			V
$R_{DS(ON)}$	Drain-Source On-State Resistance ²	$V_{GS} = 10\text{ V}, I_D = 20\text{ A}$		45	50	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\ \mu\text{A}$	2.5		4.5	V
I_{DSS}	Drain-Source Leakage Current ($T_J=25^\circ\text{C}$)	$V_{DS} = 200\text{ V}, V_{GS} = 0\text{ V}$			1	μA
	Drain-Source Leakage Current ($T_J=125^\circ\text{C}$)	$V_{DS} = 160\text{ V}, V_{GS} = 0\text{ V}$			100	
I_{GSS}	Gate-Body Leakage Current	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$			±100	nA

Dynamic Characteristics						
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{DS} = 100\text{ V}$ $V_{GS} = 0\text{ V}$ $f = 1.0\text{ MHz}$		1465		pF
C_{oss}	Output Capacitance			97		pF
C_{rss}	Reverse Transfer Capacitance			12		pF
Switching Times						
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 100\text{ V}$ $V_{GS} = 10\text{ V}$ $R_G = 3\ \Omega$ $I_D = 20\text{ A}$		17		nS
t_r	Turn-On Rise Time			4		nS
$t_{d(off)}$	Turn-Off Delay Time			23.5		nS
t_f	Turn-Off Fall Time			4.5		nS
Q_g	Total Gate Charge (10 V)	$V_{DS} = 100\text{ V}$		18.5		nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 10\text{ V}$		7.6		nC
Q_{gd}	Gate-Drain Charge	$I_D = 20\text{ A}$		3.5		nC

Source-Drain Diode Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
I_S	Continuous Source Current ^{1,5}	$V_G = V_D = 0\text{ V}$, Force Current			30	A
I_{SM}	Pulsed Source Current ^{2,5}				120	A
V_{SD}	Diode Forward Voltage ²	$I_S = 30\text{ A}$, $V_{GS} = 0\text{ V}$, $T_J = 25^\circ\text{C}$			1.2	V
t_{rr}	Reverse Recovery Time	$I_F = 15\text{ A}$, $dI/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$		140		nS
Q_{rr}	Reverse Recovery Charge				347	

Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. The data tested by pulsed : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
3. The E_{AS} data shows Max. rating . The test condition is $V_{DD} = 50\text{ V}$, $V_{GS} = 10\text{ V}$, $L = 1\text{ mH}$, $I_{AS} = 20\text{ A}$.
4. The power dissipation is limited by 150°C junction temperature.
5. The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics

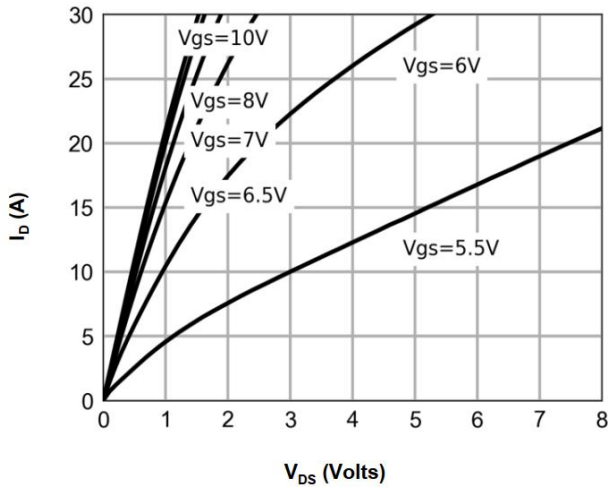


Fig.1 Typical Output Characteristics

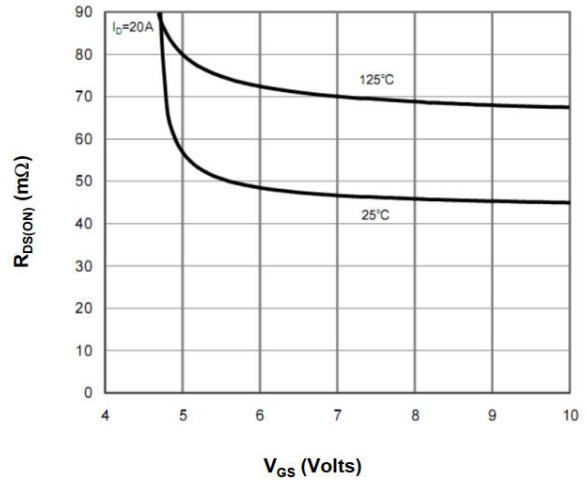


Fig.2 On-Resistance vs. G-S Voltage

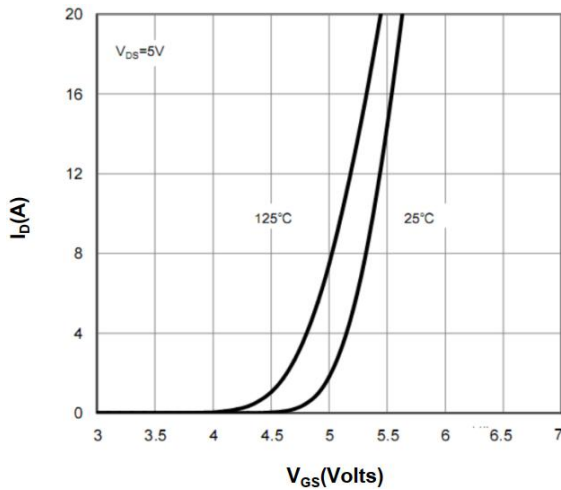


Fig.3 Transfer Characteristics

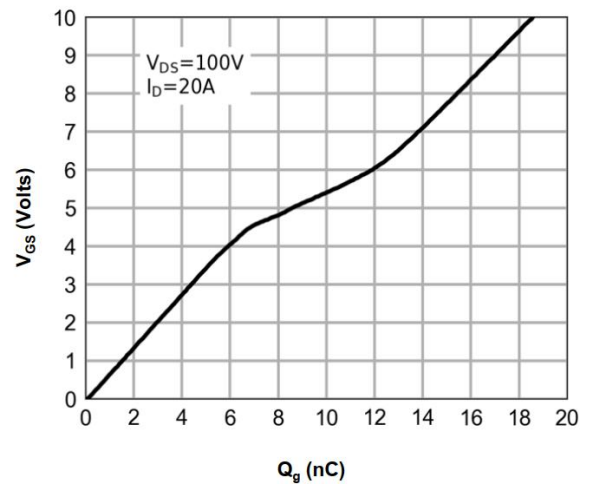


Fig.4 Gate-Charge Characteristics

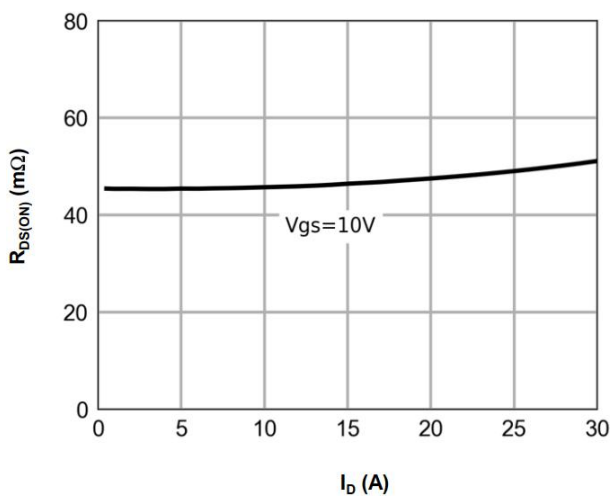


Fig.5 On-Resistance vs. Drain Current

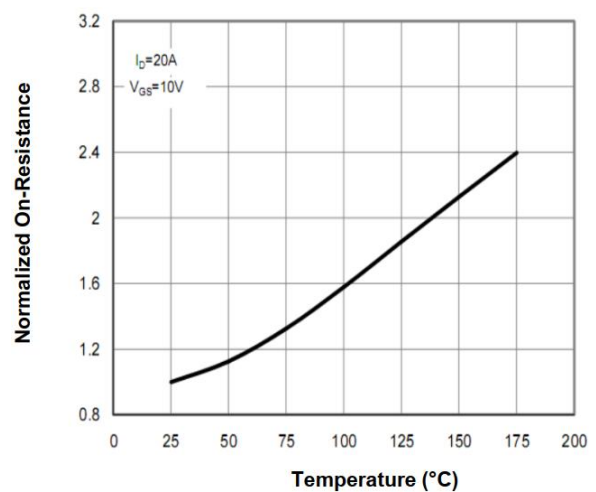


Fig.6 Normalized $R_{DS(ON)}$ vs. T_J

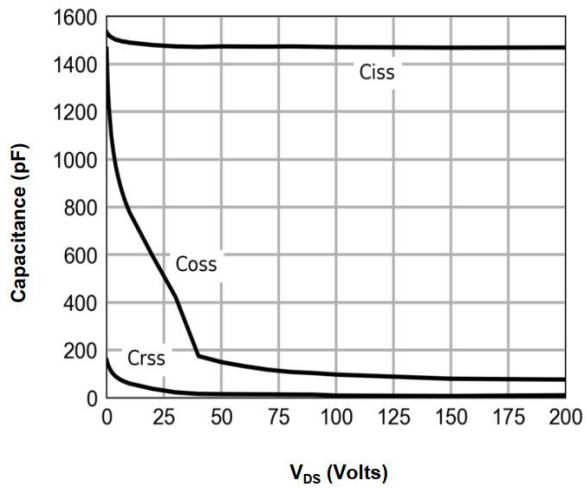


Fig.7 Capacitance

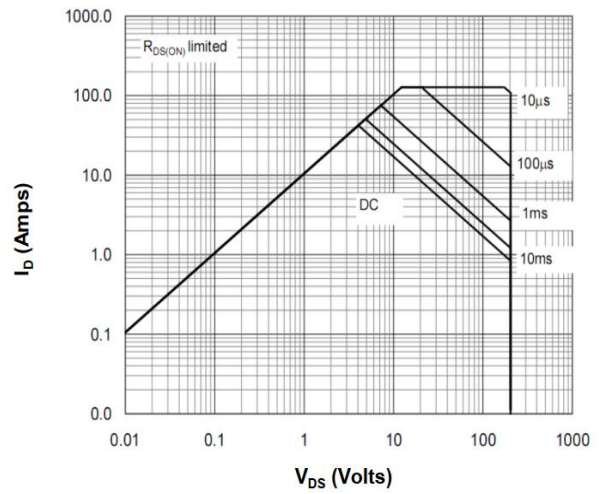


Fig.8 Safe Operating Area

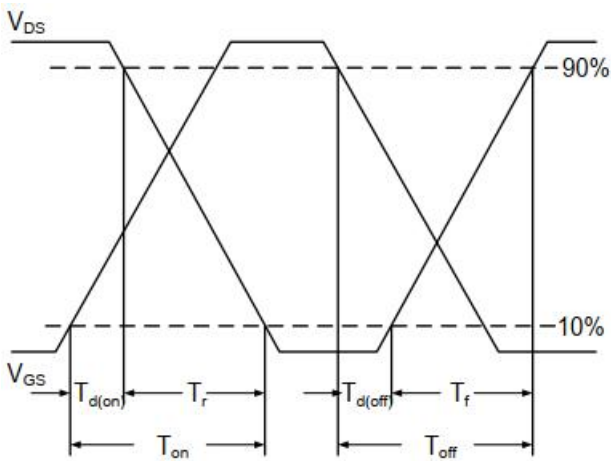


Fig.9 Switching Time Waveform

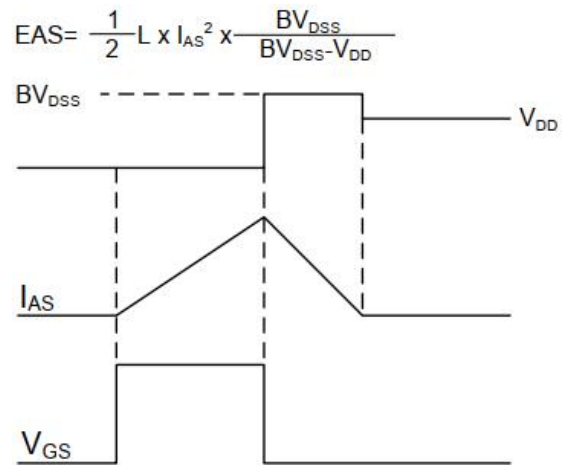
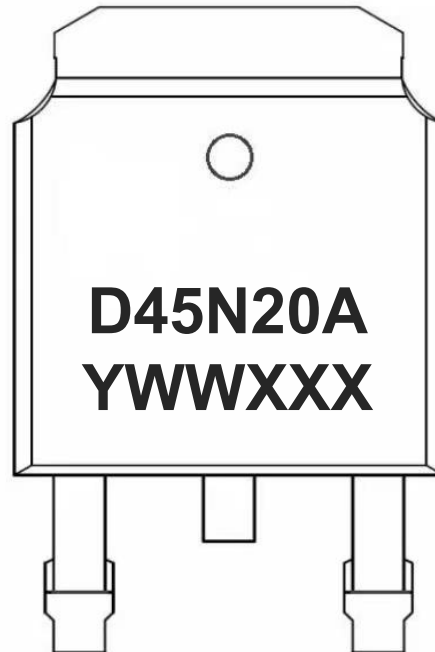


Fig.10 Unclamped Inductive Switching Waveform

$$EAS = \frac{1}{2} L \times I_{AS}^2 \times \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$

Marking Information



1 st line: HuaYuanWei Logo (left)

2 nd line: Device Package, Part Number, Channel and Version

3 rd line: Date Code [Y WW XX X]

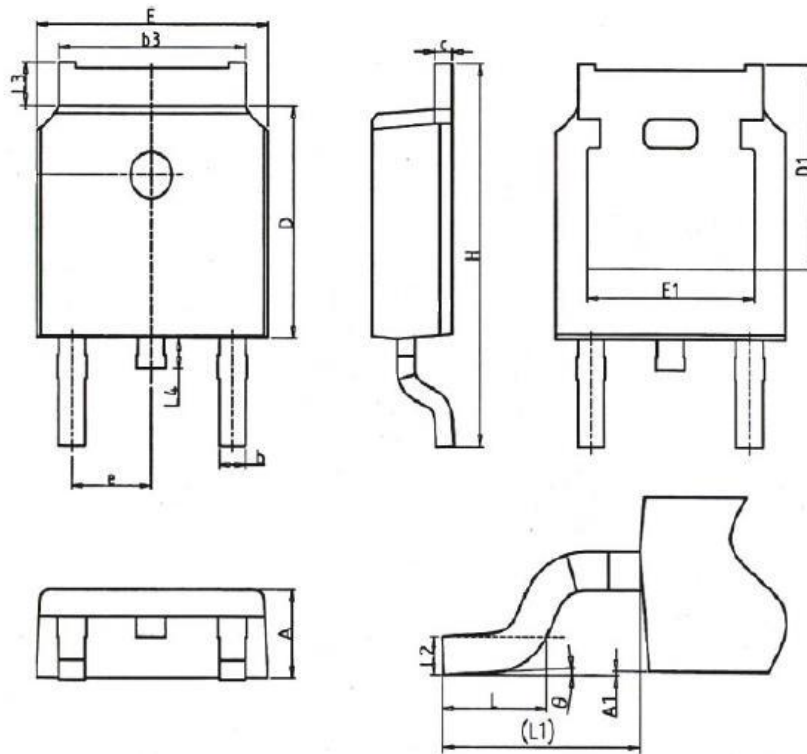
① **Y** : Year (2021=M, 2022=N.....)

② **WW** : Week (01-53)

③ **XX** : Serial Number (01-99, AA-ZZ)

④ **X** : Factory Code (A-Z)

TO-252 Package Outline



SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.18	2.40	0.086	0.095
A1	-	0.2	-	0.008
b	0.68	0.9	0.026	0.036
b3	4.95	5.46	0.194	0.215
c	0.43	0.89	0.017	0.035
D	5.97	6.22	0.235	0.245
D1	5.300REF		0.209REF	
E	6.35	6.73	0.250	0.265
E1	4.32	--	0.170	-
e	2.286BSC		0.09BSC	
H	9.4	10.5	0.370	0.413
L	1.38	1.78	0.054	0.070
L1	2.90REF		0.114REF	
L2	0.51BSC		0.020BSC	
L3	0.88	1.28	0.034	0.050
L4	0.5	1	0.019	0.039
Θ	0°	8°	0°	8°